

# SLM50D06T

## 60V N-Channel MOSFET

### General Description

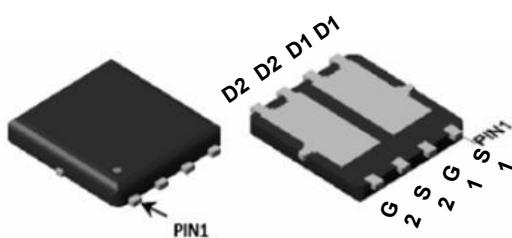
This Power MOSFET is produced using Msemitek's advanced TRENCH technology. This advanced technology has been especially tailored to minimize conduction loss, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

### Application

- PWM Application
- Load Switch
- Power Management

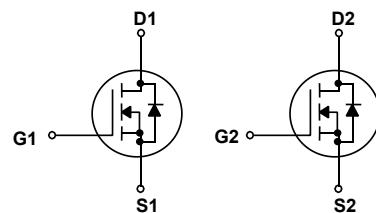
### Features

- N-Channel: 60V 50A
- $R_{DS(on)Typ} = 14.8\text{m}\Omega @ VGS = 10\text{V}$
- $R_{DS(on)Typ} = 18.2\text{m}\Omega @ VGS = 4.5\text{V}$
- Very Low On-resistance  $R_{DS(ON)}$
- Low Crss
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



Top View

Bottom View



### Absolute Maximum Ratings

$T_C = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	SLM50D06T	Units
$V_{DSS}$	Drain-Source Voltage	60	V
$I_D$	Drain Current - Continuous ( $T_C = 25^\circ\text{C}$ )	50	A
	- Continuous ( $T_C = 100^\circ\text{C}$ )	33	A
$I_{DM}$	Drain Current - Pulsed	(Note 1)	A
$V_{GSS}$	Gate-Source Voltage	$\pm 30$	V
EAS	Single Pulsed Avalanche Energy	(Note 2)	mJ
$E_{AR}$	Repetitive Avalanche Energy	(Note 1)	mJ
$P_D$	Power Dissipation ( $T_C = 25^\circ\text{C}$ )	89	W
$R_{eJC}$	Thermal Resistance, Junction to Case	1.4	$^\circ\text{C}/\text{W}$
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to +175	$^\circ\text{C}$
$T_L$	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	$^\circ\text{C}$

\* Drain current limited by maximum junction temperature.

## Package Marking

Part Number	Top Marking	Package	Packing Method	MOQ	QTY
SLM50D06T	SLM50D06T	PDFN5*6	Tape & Reel	5000	50000

## Electrical Characteristics

$T_C = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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### Off Characteristics

$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}} = 0 \text{ V}, I_D = 250 \mu\text{A}$	60	--	--	V
$\Delta \text{BV}_{\text{DSS}} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$ , Referenced to $25^\circ\text{C}$	--	0.06	--	$\text{V}/^\circ\text{C}$
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 60 \text{ V}, V_{\text{GS}} = 0 \text{ V}$	--	--	1	$\mu\text{A}$
		$V_{\text{DS}} = 48 \text{ V}, T_C = 150^\circ\text{C}$	--	--	10	$\mu\text{A}$
$I_{\text{GSSF}}$	Gate-Body Leakage Current, Forward	$V_{\text{GS}} = 20 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	100	nA
$I_{\text{GSSR}}$	Gate-Body Leakage Current, Reverse	$V_{\text{GS}} = -20 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	-100	nA

### On Characteristics

$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250 \mu\text{A}$	1.0	--	2.5	V
$R_{\text{DS(on)}}$	Static Drain-Source On-Resistance	$V_{\text{GS}} = 10 \text{ V}, I_D = 20 \text{ A}$	--	14.8	16	$\text{m}\Omega$
		$V_{\text{GS}} = 4.5 \text{ V}, I_D = 20 \text{ A}$	--	18.2	24	

### Dynamic Characteristics

$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}} = 25 \text{ V}, V_{\text{GS}} = 0 \text{ V}, f = 1.0 \text{ MHz}$	--	2780	--	pF
$C_{\text{oss}}$	Output Capacitance		--	112	--	pF
$C_{\text{rss}}$	Reverse Transfer Capacitance		--	103	--	pF

### Switching Characteristics

$t_{\text{d(on)3}}$	Turn-On Delay Time	$V_{\text{DD}} = 30 \text{ V}, I_D = 25 \text{ A}, R_G = 25 \Omega$ (Note 3)	--	15	--	ns
$t_r$	Turn-On Rise Time		--	105	--	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time		--	60	--	ns
$t_f$	Turn-Off Fall Time		--	65	--	ns
$Q_g$	Total Gate Charge	$V_{\text{DS}} = 30 \text{ V}, I_D = 20 \text{ A}, V_{\text{GS}} = 4.5 \text{ V}$ (Note 3)	--	26.6	--	nC
$Q_{\text{gs}}$	Gate-Source Charge		--	7.7	--	nC
$Q_{\text{gd}}$	Gate-Drain Charge		--	11.2	--	nC
$R_G$	Gate Resistance	$f = 1\text{MHz}$	--	-	--	$\Omega$

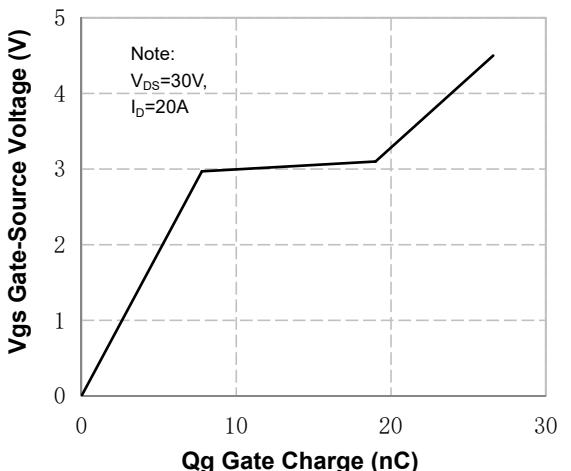
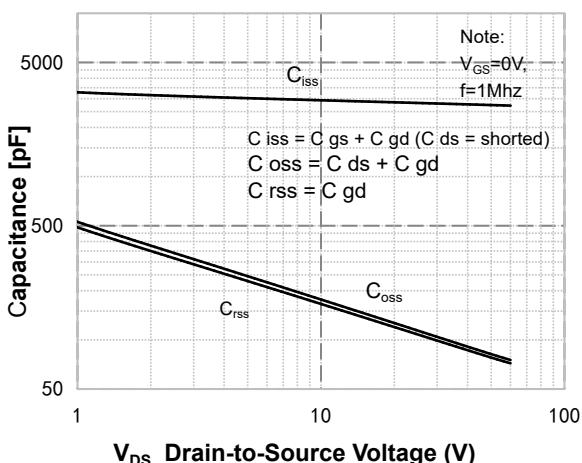
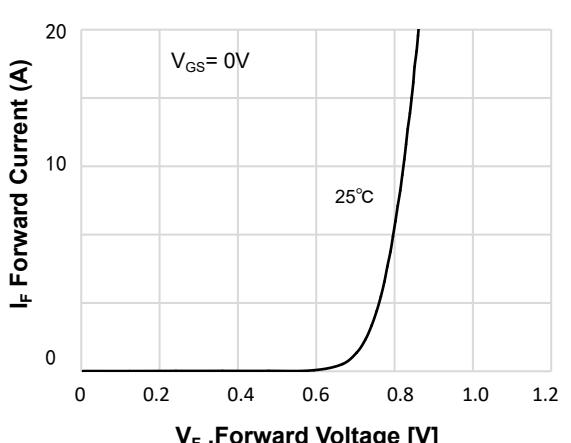
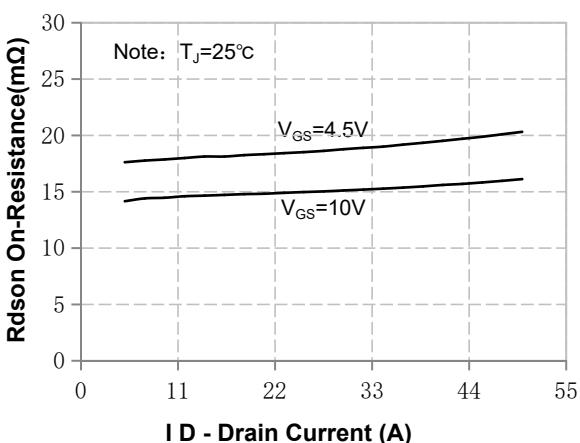
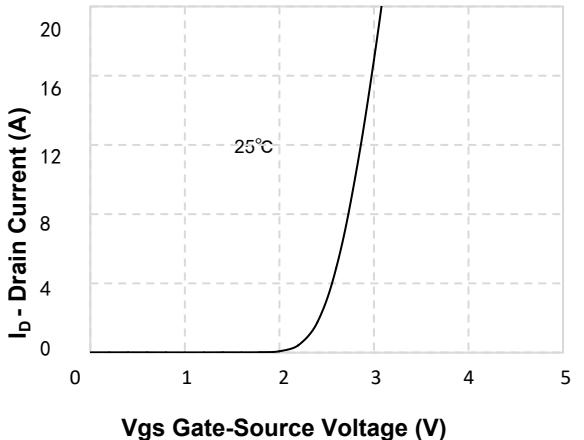
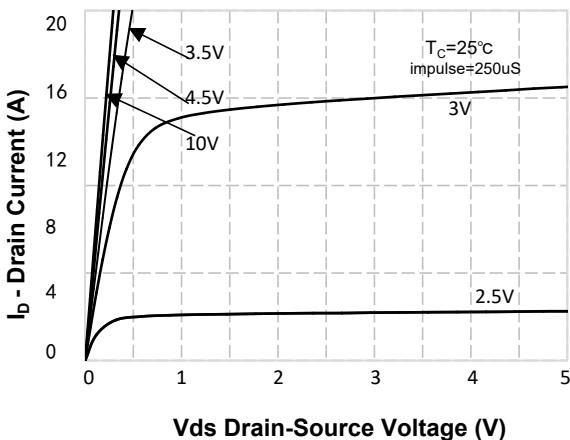
### Drain-Source Diode Characteristics and Maximum Ratings

$I_S$	Maximum Continuous Drain-Source Diode Forward Current	--	--	50	A
$I_{\text{SM}}$	Maximum Pulsed Drain-Source Diode Forward Current	--	--	200	A
$V_{\text{SD}}$	Drain-Source Diode Forward Voltage	$V_{\text{GS}} = 0 \text{ V}, I_S = 50 \text{ A}$	--	--	1.4

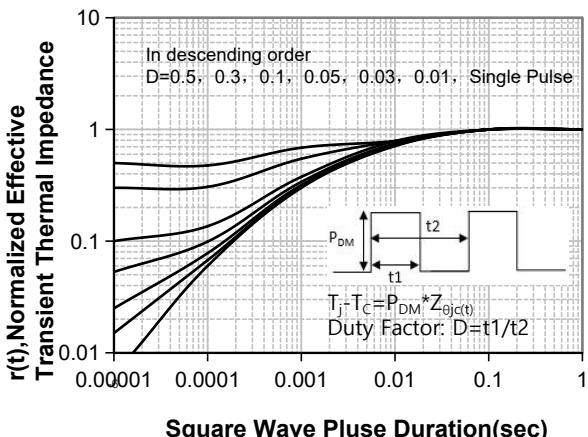
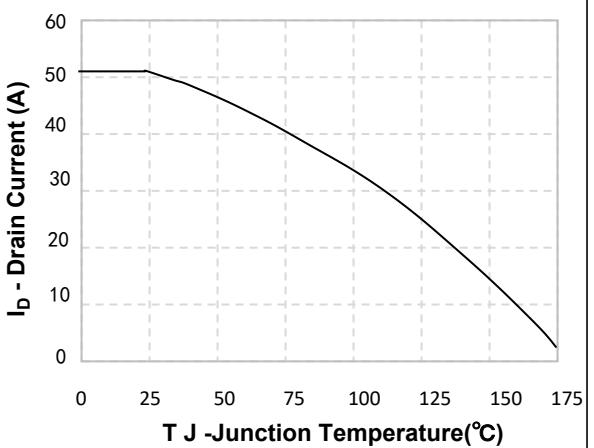
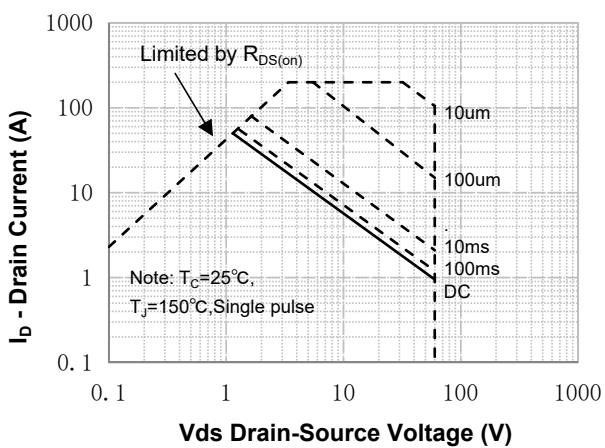
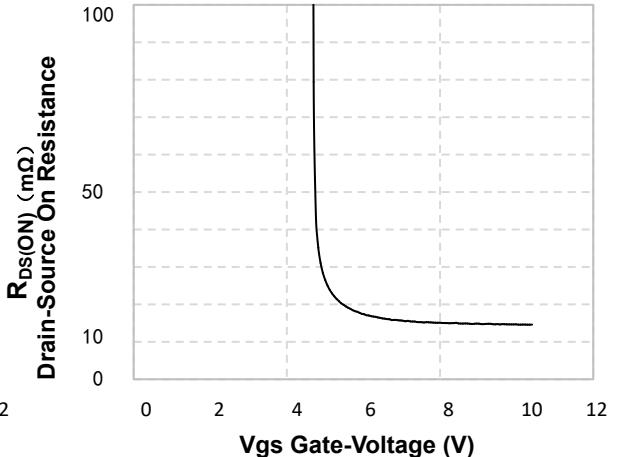
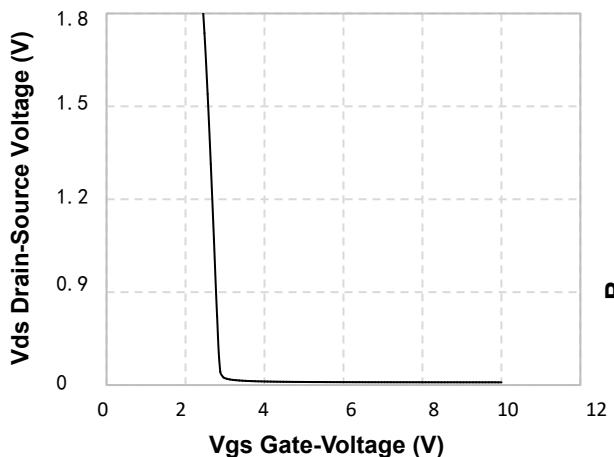
#### Notes:

- Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
- EAS condition:  $T_J = 25^\circ\text{C}$ ,  $V_{\text{DD}} = 20 \text{ V}$ ,  $V_G = 10 \text{ V}$ ,  $L = 0.5 \text{ mH}$ .
- Pulse Test: Pulse Width  $\leq 300 \mu\text{s}$ , Duty Cycle  $\leq 0.5\%$

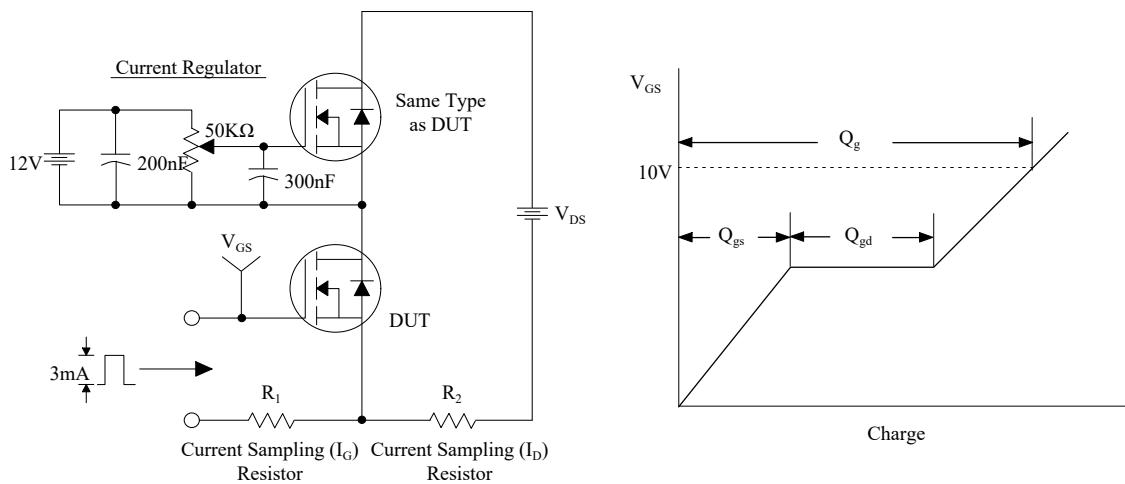
## N-Channel Typical Characteristics



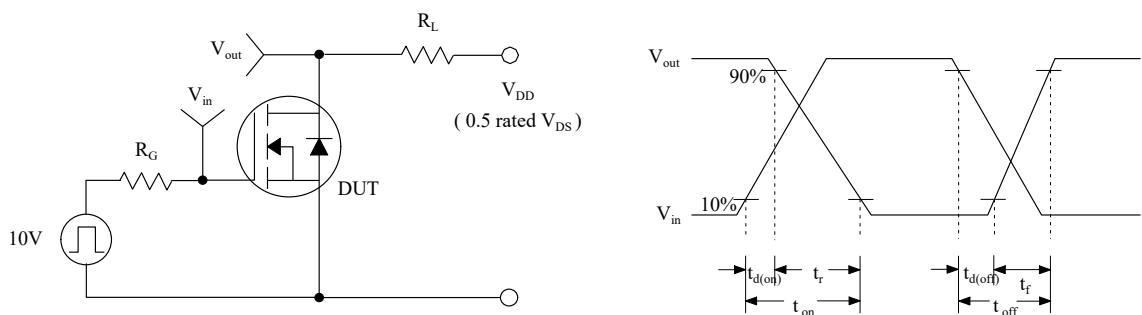
## N-Channel Typical Characteristics (Continued)



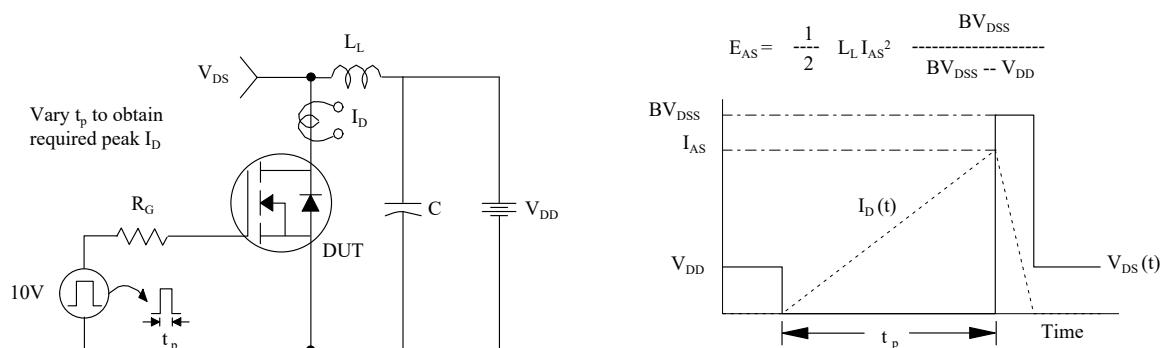
## Gate Charge Test Circuit & Waveform



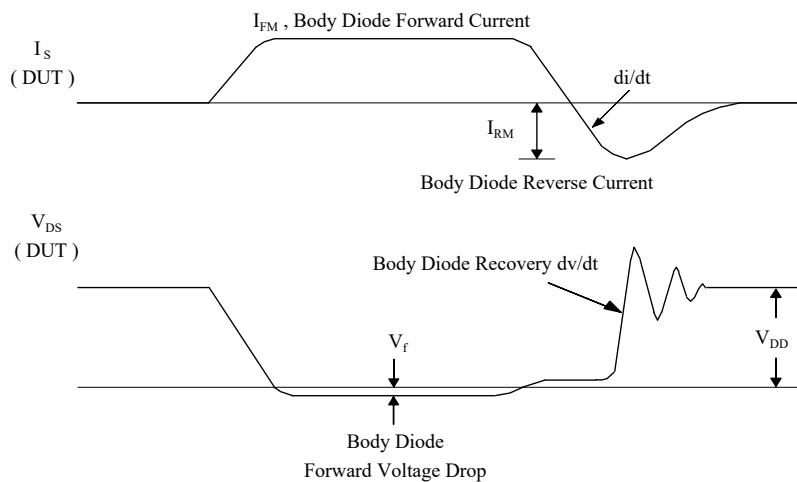
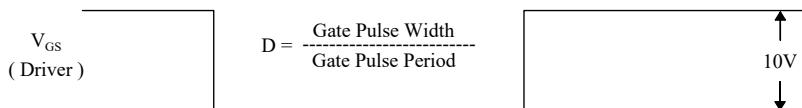
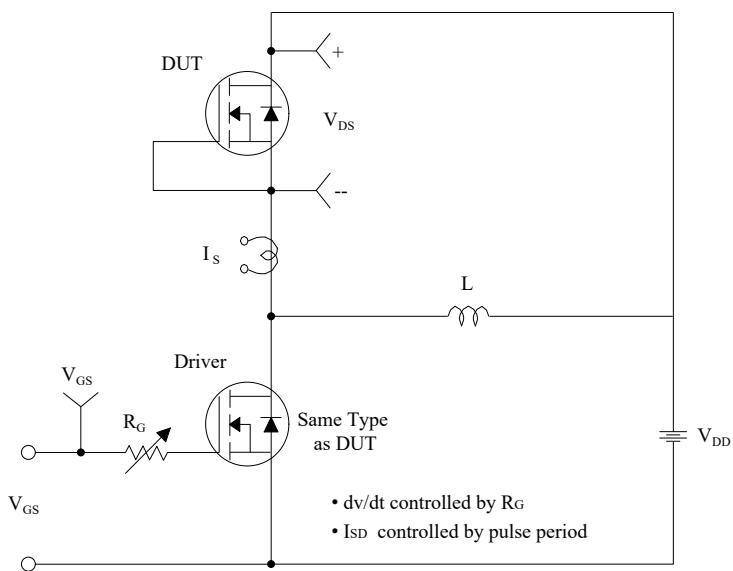
## Resistive Switching Test Circuit & Waveforms



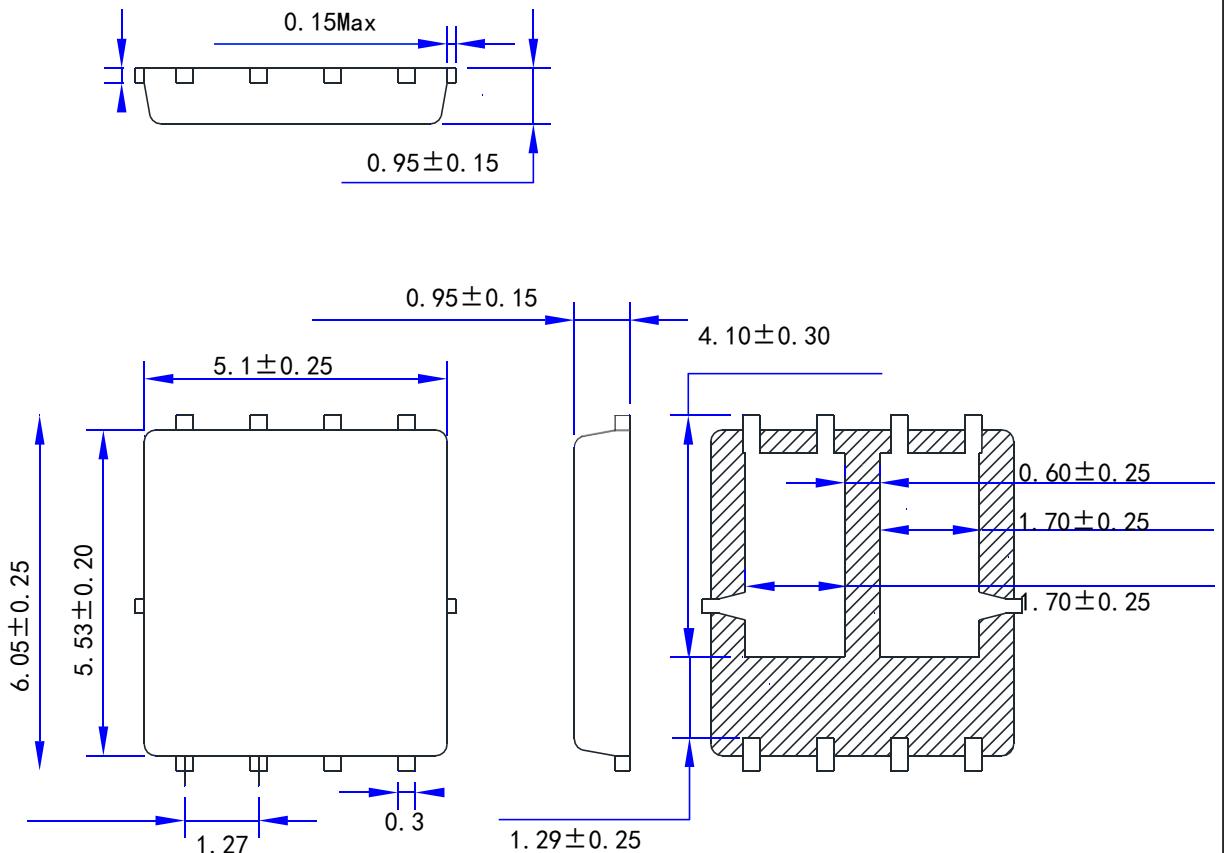
## Unclamped Inductive Switching Test Circuit & Waveforms



## Peak Diode Recovery dv/dt Test Circuit & Waveforms



# DFN 5\*6 Double Base OUTLINE



## NOTE:

- 1The plastic package is not marked as smooth surfaceRa=0.1;Subglossy surfaceRa=0.8
- 2Undeclared tolerance $\pm 0.15$ ,Unmarked filletRmax=0.25

NAME	DFN5*6-Double OUTLINE	UNIT	mm	DESIGNED	Shawn Chen	THIRD ANGLE SYSTEM
DWGNO		PAGE	1 OF 1	CHECKED		
VERSION	Ver1.0	ISSUE DATE		APPROVED		

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